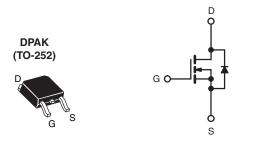


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.54		
Q _g (Max.) (nC)	8.3			
Q _{gs} (nC)	2.3			
Q _{gd} (nC)	3.8			
Configuration	Single			



N-Channel MOSFET

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Surface Mount (IRFR110, SiHFR110)
- Available in Tape and Reel
- · Fast Switching
- · Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

Available ROHS* COMPLIANT HALOGEN

FREE

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. Power dissipation levels up to 1.5 W are possible in typical surface mount applications.

ORDERING INFORMATION					
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	
Lead (Pb)-free and Halogen-free	SiHFR110-GE3	SiHFR110TRL-GE3	SiHFR110TR-GE3	SiHFR110TRR-GE3	
Lead (Pb)-free	IRFR110PbF	IRFR110TRLPbFa	IRFR110TRPbFa	IRFR110TRRPbFa	
	SiHFR110-E3	SiHFR110TL-E3 ^a	SiHFR110T-E3a	SiHFR110TR-E3a	
SnPb	IRFR110	IRFR110TRL ^a	IRFR110TRa	-	
	SiHFR110	SiHFR110TL ^a	SiHFR110T ^a	-	

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100		
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	\/ at 10 \/	T _C = 25 °C	l _D	4.3		
	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		2.7	Α	
Pulsed Drain Current ^a			I _{DM}	17		
Linear Derating Factor				0.20	W/°C	
Linear Derating Factor (PCB Mount)e				0.020	VV/ C	
Single Pulse Avalanche Energy ^b			E _{AS}	75	mJ	
Repetitive Avalanche Current ^a			I _{AR}	4.3	Α	
Repetitive Avalanche Energy ^a			E _{AR}	2.5	mJ	
Maximum Power Dissipation	T _C = 25 °C		D 25	W		
Maximum Power Dissipation (PCB Mount)e	T _A = 25 °C		P_{D}	2.5] vv	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	T _J , T _{stg} - 55 to + 150		
Soldering Recommendations (Peak Temperature)	for 10 s		-	260 ^d	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 8.1 \,^{\circ}\text{mH}$, $R_g = 25 \,^{\circ}\text{C}$, $I_{AS} = 4.3 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFR110, SiHFR110

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	110		
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	50	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	5.0		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static				•		•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	V _{GS} = 0 V, I _D = 250 μA		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
		V _{DS} =	= 100 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V	, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.6 A ^b	-	-	0.54	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 2.6 A	1.6	-	-	S
Dynamic		-					
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	180	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$		80	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	15	-	
Total Gate Charge	Qg		$V_{GS} = 10 \text{ V}$ $I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	8.3	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	2.3	
Gate-Drain Charge	Q _{gd}			-	-	3.8	
Turn-On Delay Time	t _{d(on)}		V _{DD} = 50 V, I _D = 5.6 A,		6.9	-	- ns
Rise Time	t _r	V _{DD} =			16	-	
Turn-Off Delay Time	t _{d(off)}	$R_g = 24 \Omega$, $R_D = 8.4 \Omega$, see fig. 10^b		-	15	-	
Fall Time	t _f	1			9.4	-	
Internal Drain Inductance	L _D	6 mm (0.25") t	Between lead, 6 mm (0.25") from package and center of die contact		4.5	-	
Internal Source Inductance	L _S				7.5	-	nH
Drain-Source Body Diode Characteristic	s	•					
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the		-	4.3	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	17	A
Body Diode Voltage	V _{SD}	T _J = 25 °C	$T_J = 25$ °C, $I_S = 4.3$ A, $V_{GS} = 0$ V ^b		-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.6 A, dI/dt = 100 A/μs ^b		-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.44	0.88	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300 \,\mu\text{s}$; duty cycle $\leq 2 \,\%$.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

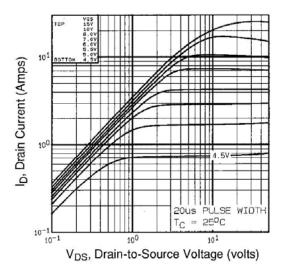


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

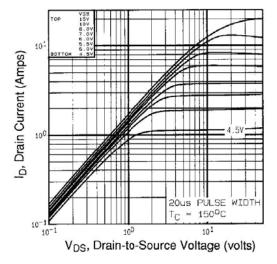


Fig. 2 -Typical Output Characteristics, T_C = 150 °C

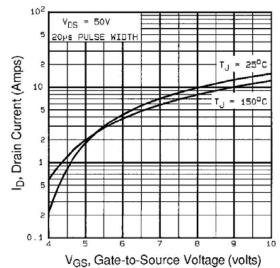


Fig. 3 - Typical Transfer Characteristics

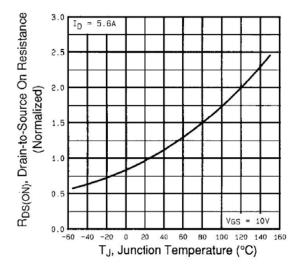


Fig. 4 - Normalized On-Resistance vs. Temperature

Vishay Siliconix



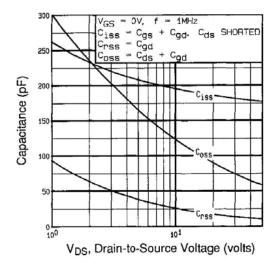


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

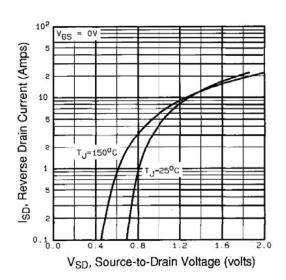


Fig. 7 - Typical Source-Drain Diode Forward Voltage

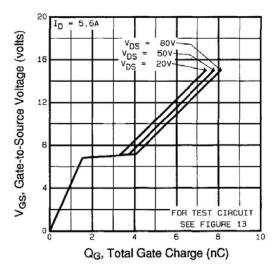


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

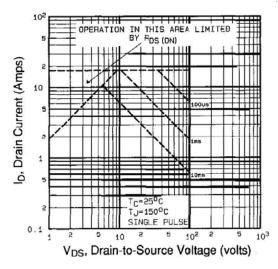


Fig. 8 - Maximum Safe Operating Area





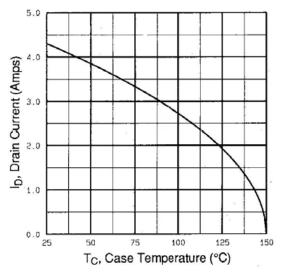


Fig. 9 - Maximum Drain Current vs. Case Temperature

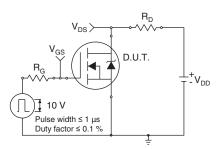


Fig. 10a - Switching Time Test Circuit

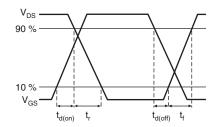


Fig. 10b - Switching Time Waveforms

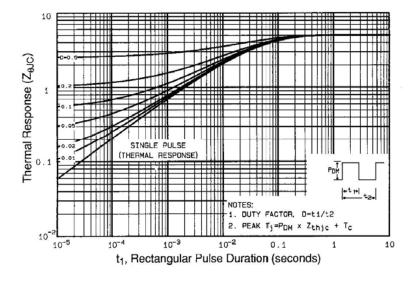


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

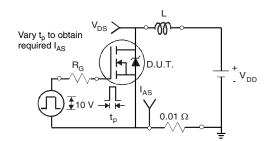


Fig. 12a - Unclamped Inductive Test Circuit

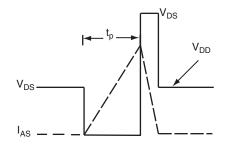


Fig. 12b - Unclamped Inductive Waveforms

Vishay Siliconix



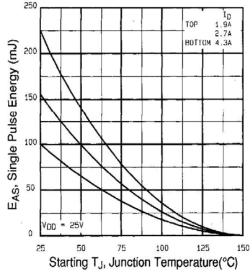


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

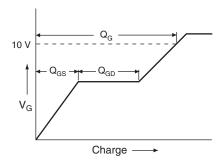


Fig. 13a - Basic Gate Charge Waveform

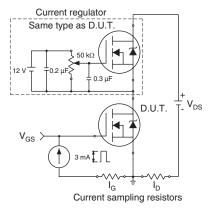
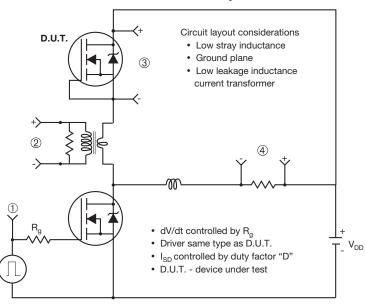


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



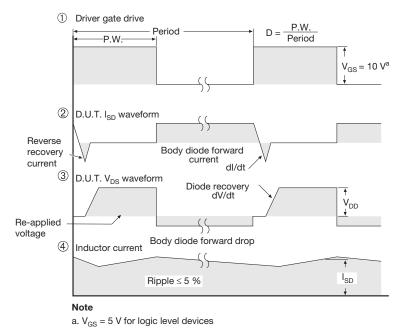


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91265.

Legal Disclaimer Notice



Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and/or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk and agree to fully indemnify and hold Vishay and its distributors harmless from and against any and all claims, liabilities, expenses and damages arising or resulting in connection with such use or sale, including attorneys fees, even if such claim alleges that Vishay or its distributor was negligent regarding the design or manufacture of the part. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

Document Number: 91000 www.vishay.com
Revision: 11-Mar-11 1